Notice of References Cited Application/Control No. 09/739,817 Examiner JOHN J LEE Applicatios/Patent Under Reexamination MIYANO ET AL. Art Unit 2684 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,649,393	03-1987	Rittenbach, Otto E.	342/371
	В	US-5,305,353	04-1994	Weerackody, Vijitha	375/347
	С	US-5,568,158	10-1996	Gould, Harry J.	455/278.1
	D	US-6,538,608	03-2003	Muramoto et al.	343/702
	Е	US-			
	F	US-			
	G	US-		·	
	Н	US-			
	1	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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NON-PATENT DOCUMENTS

	NON I ATEN BOSSMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.